Application/Control No. 10/042,229 Examiner Venkataraman Applicant(s)/Patent Under Reexamination FURUYA ET AL. Art Unit Page 1 of 1

Notic of Referenc s Cited

	U.S. PATENT DOCUMENTS					
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification	
	Α	US-				
	В	US-				
	С	US-				
	D	US-				
	E	US-				
	F	US-			-	
	G	US-				
	Н	US-				
	_	US-			9	
	J	US-				
	К	US-				
	L	US-				
	М	US-				

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FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	Р					
	α					
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	S					
	Т					

NON-PATENT DOCUMENTS

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*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Huirne, JA, and Lambalk, GB., Lancet 358(9295): 1793-1803, 2001.
	v	
	w	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.